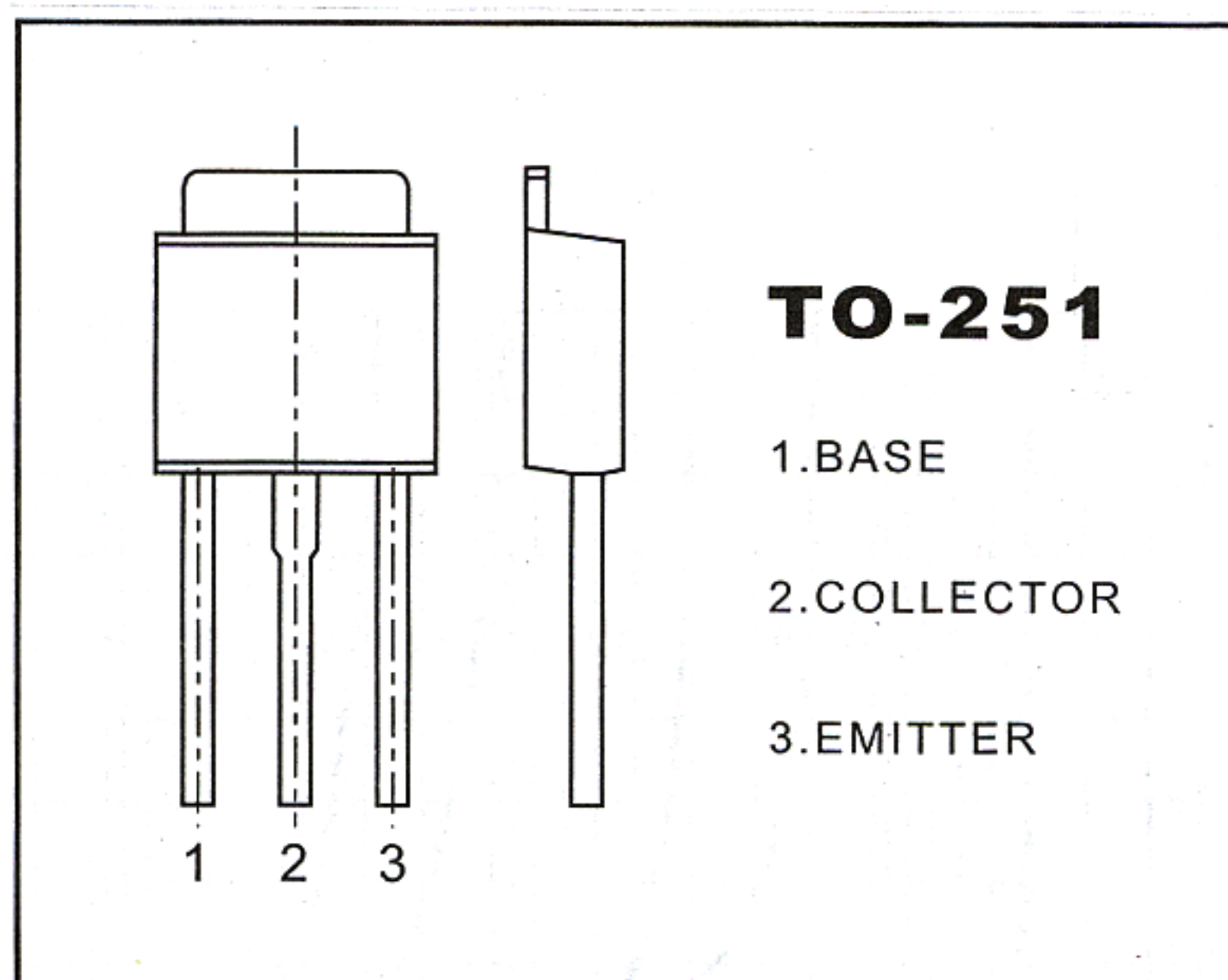


TO-251 Plastic-Encapsulate Transistors

3DD13002 TRANSISTOR(NPN)



FEATURES

Power dissipation

P_{CM} : 1.25W ($T_{amb}=25^{\circ}C$)

Collector current

I_{CM} : 1 A

Collector-base voltage

$V_{(BR)CBO}$: 600 V

Operating and storage junction temperature range

T_J, T_{stg} : $-55^{\circ}C$ to $+150^{\circ}C$

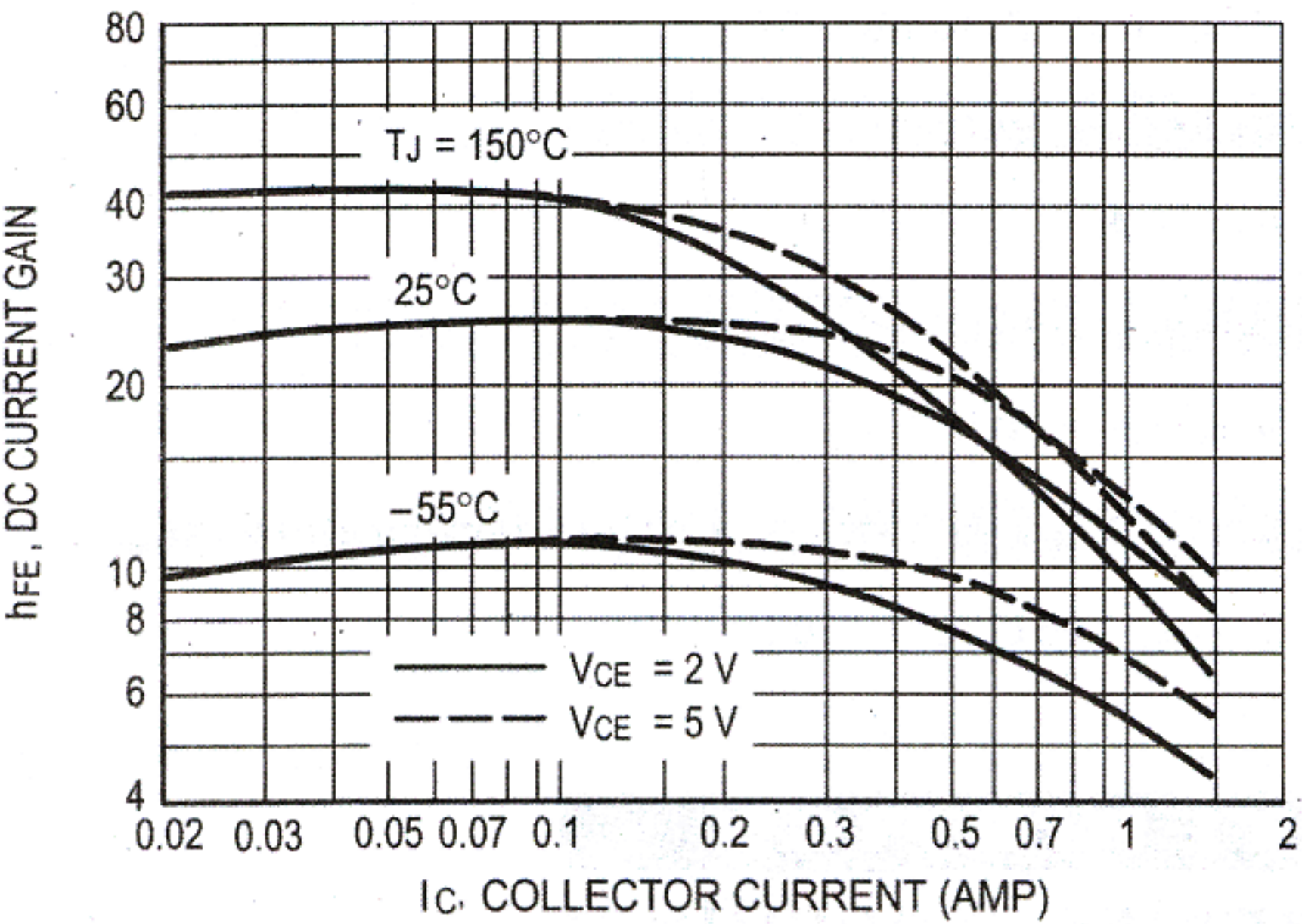
ELECTRICAL CHARACTERISTICS

($T_{amb}=25^{\circ}C$ unless otherwise specified)

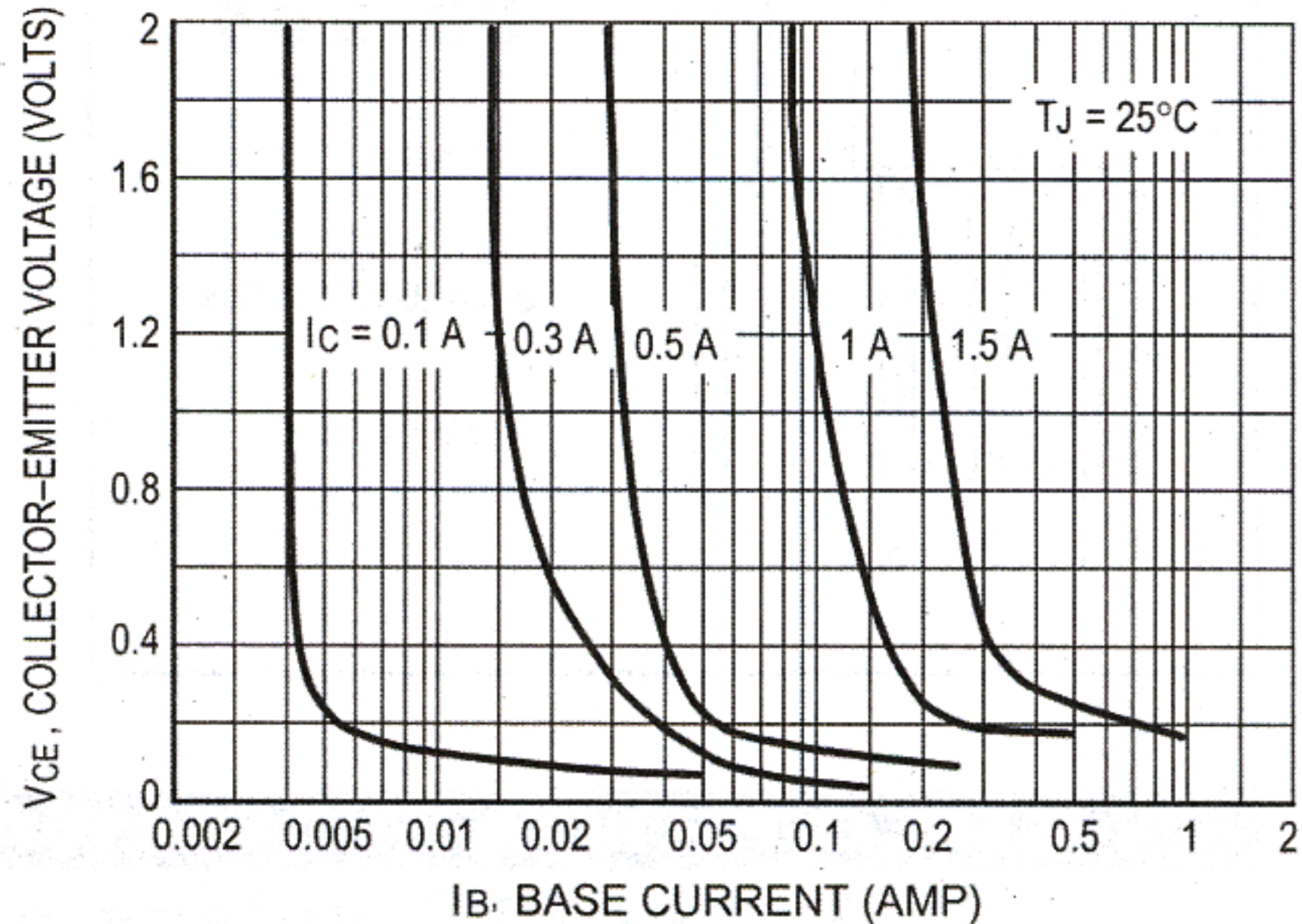
Parameter	Symbol	Test conditions	MIN	MAX	UNIT
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C = 100 \mu A, I_E = 0$	600		V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C = 1 mA, I_B = 0$	400		V
Emitter-base breakdown voltage	$V_{(BR)EBO}$	$I_E = 100 \mu A, I_C = 0$	6		V
Collector cut-off current	I_{CBO}	$V_{CB} = 600 V, I_E = 0$		100	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = 6 V, I_C = 0$		100	μA
DC current gain	$h_{FE(1)}$	$V_{CE} = 10 V, I_C = 100 mA$	8	60	
	$h_{FE(2)}$	$V_{CE} = 10 V, I_C = 200 mA$	9	40	
	$h_{FE(3)}$	$V_{CE} = 10 V, I_C = 10 mA$	6		
Collector-emitter saturation voltage	V_{CEsat}	$I_C = 200 mA, I_B = 40 mA$		0.8	V
Base-emitter voltage	V_{BEsat}	$I_C = 200 mA, I_B = 40 mA$		1.1	V
Transition frequency	f_T	$V_{CE} = 10 V, I_C = 100 mA$	5		MHz
		$f = 1 MHz$			
Fall time	t_f	$I_C = 1 A, I_{B1} = -I_{B2} = 0.2 A,$		0.5	μS
Storage time	t_s	$V_{CC} = 100V$		2.5	μS

CLASSIFICATION OF $h_{FE(2)}$

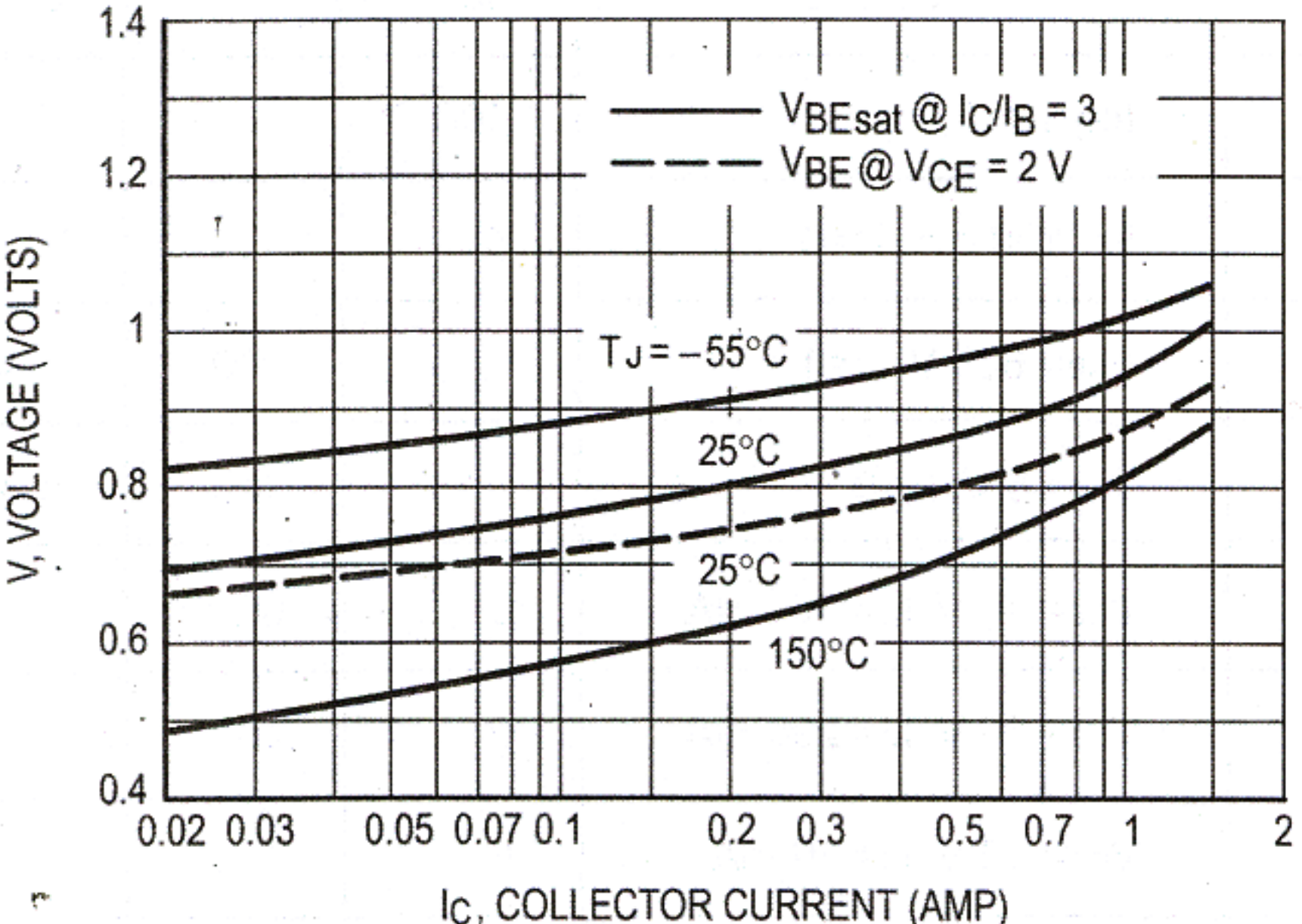
Rank						
Range	9-15	15-20	20-25	25-30	30-35	35-40



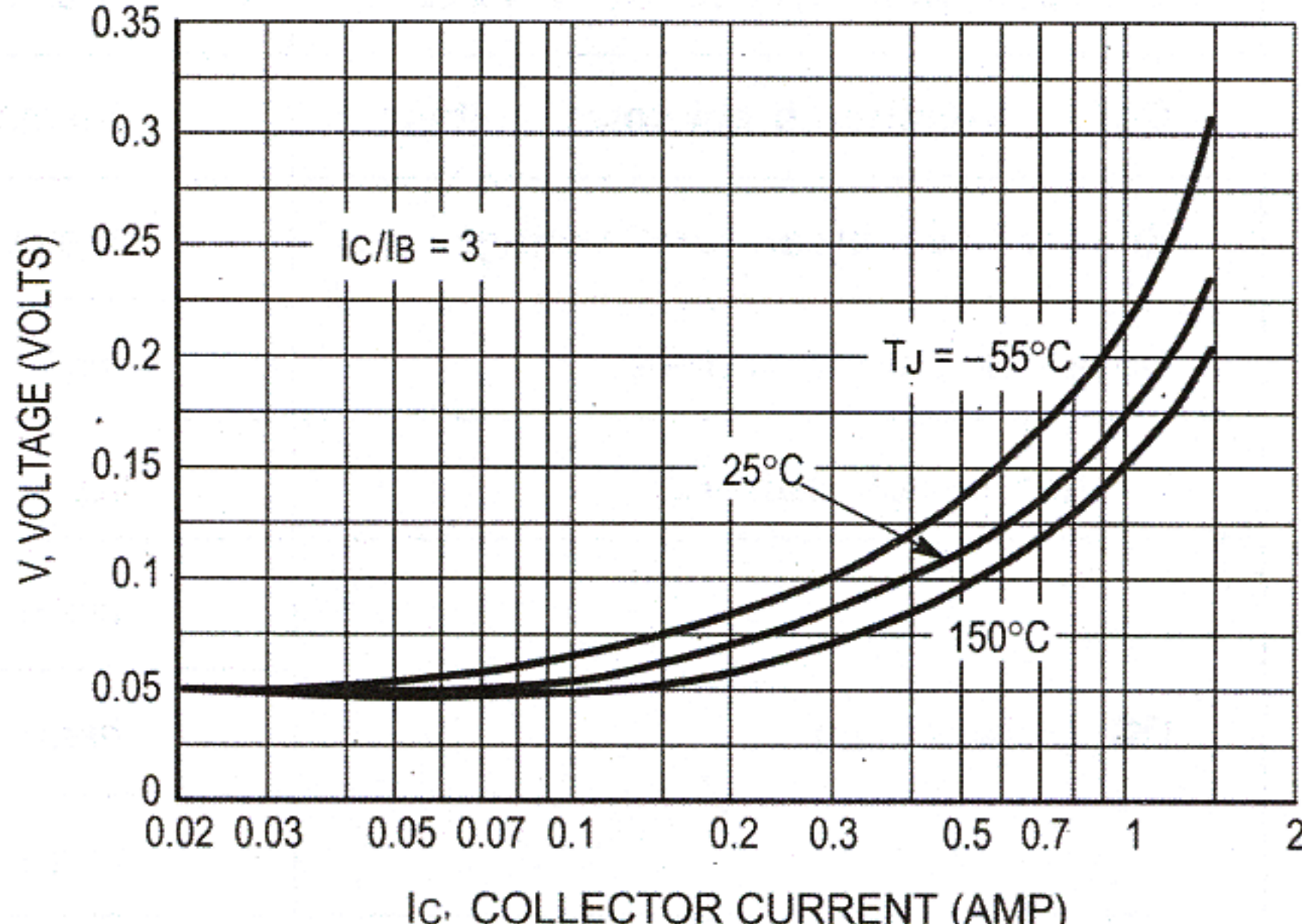
DC Current Gain



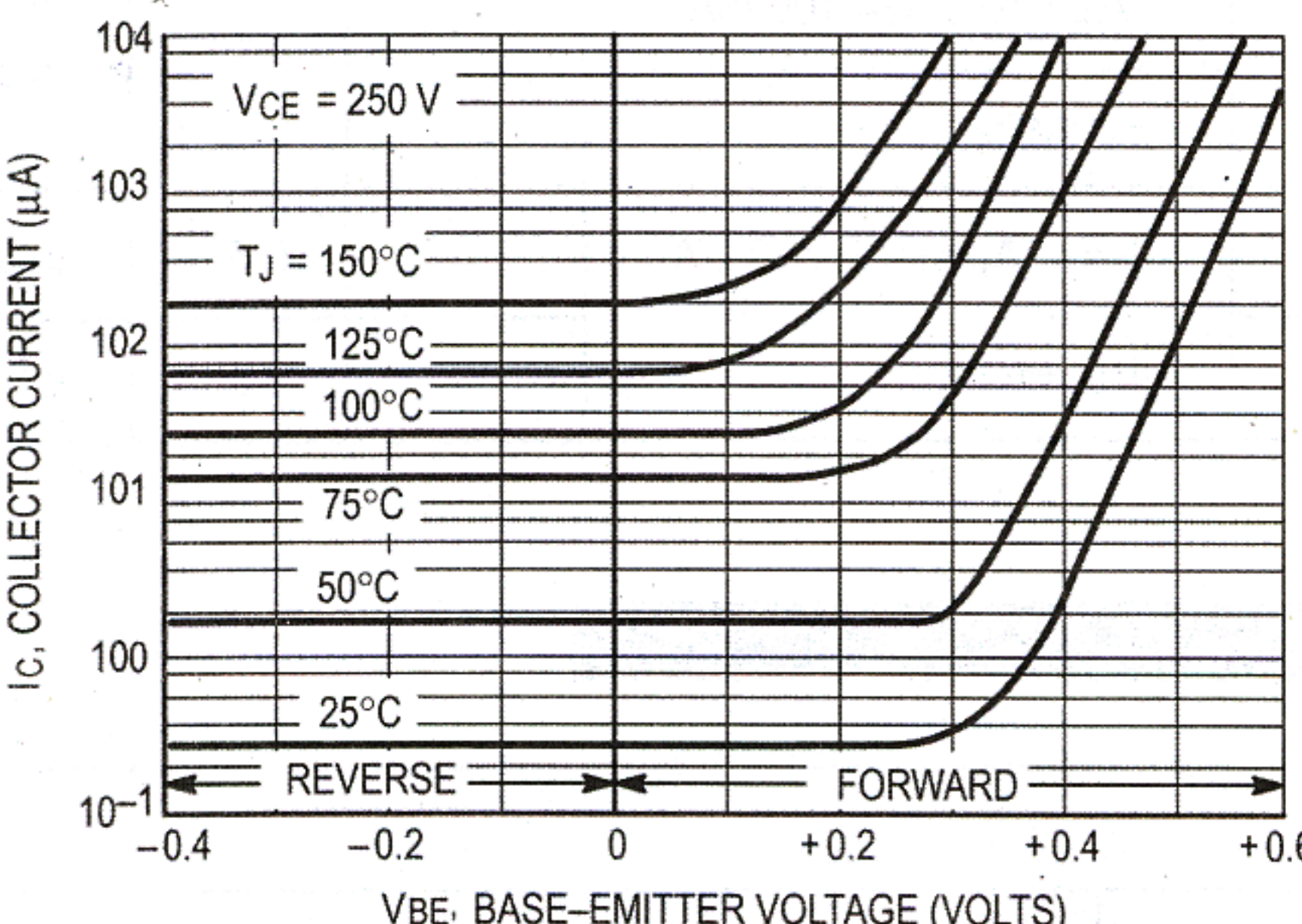
Collector Saturation Region



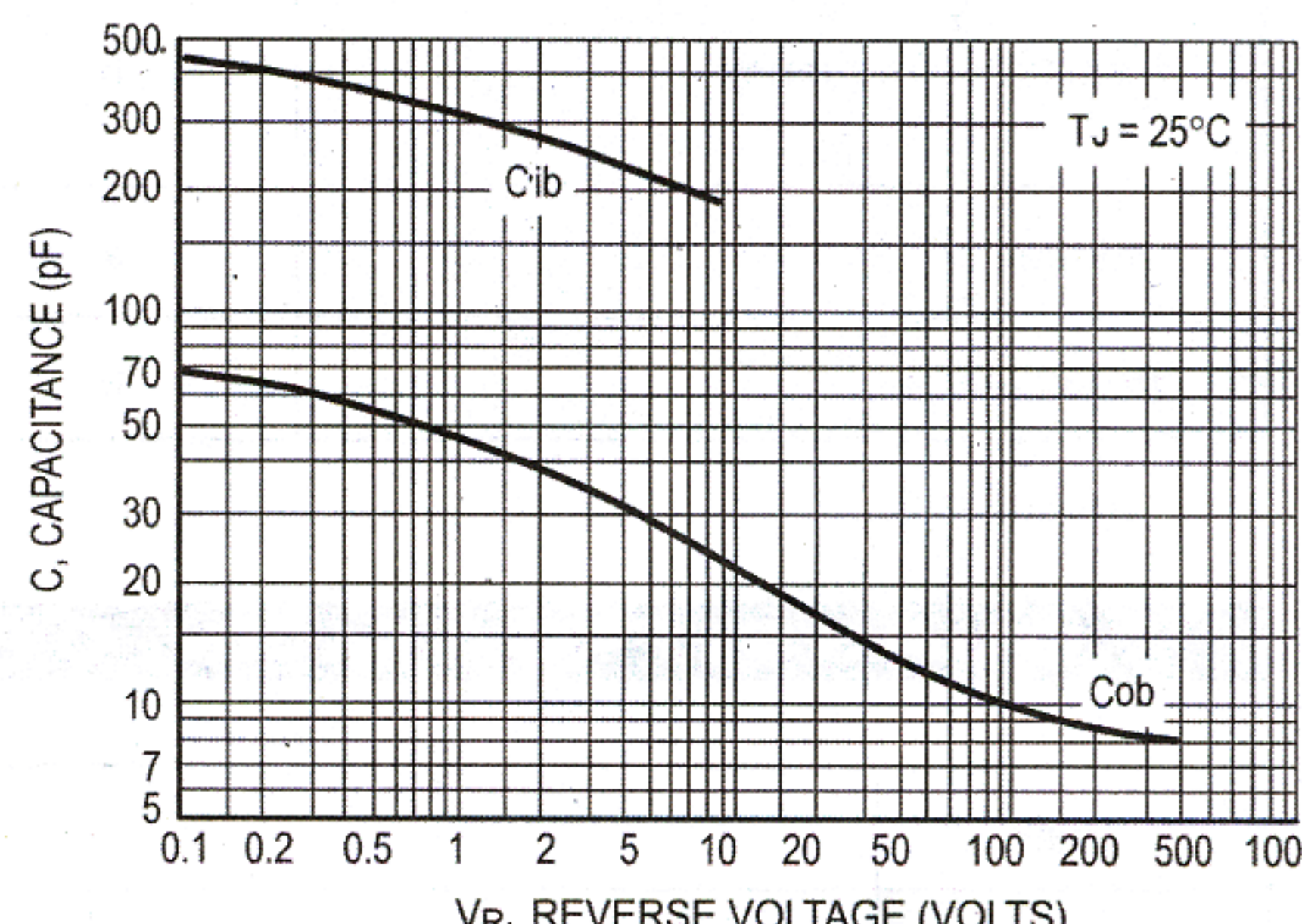
Base-Emitter Voltage



Collector-Emitter Saturation Region



Collector Cutoff Region



Capacitance